



SHEET 1 OF 1

INFORMATION DISCLOSURE CITATION IN AN APPLICATION (PTO-1449)	ATTY. DOCKET NO. 60188-641	SERIAL NO. 10/653,200
	APPLICANT Kolchi KAWASHIMA	
	FILING DATE September 03, 2003	GROUP

U.S. PATENT DOCUMENTS

EXAMINER'S INITIALS	CITE NO.	Document Number Number-Kind Code2 (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
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FOREIGN PATENT DOCUMENTS

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						Yes	No

OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)

EXAMINER'S INITIALS	CITE NO.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.
3A		T. TOKUYAMA, "Semiconductor Dry Etching Technique", October 6, 1992, pages 81-88 (Partial English Translation).

EXAMINER Shamim Ahmed	DATE CONSIDERED 9/26/05
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*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

1 Applicant's unique citation designation number (optional). 2 Applicant is to place a check mark here if English language Translation is attached.



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SA		US 2003/0000920 A1	1/2/2003	Lee	Corresponds to JP 2003-133295
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SA		JP 2003-133295 A	5/9/2003	HYNIX SEMICONDUCTOR INC.	Corresponds to US 2003/0000920	w/English abstract
		JP 06-349784	12/22/1994	LAERMER FRANZ SCHILP ANDREA	Corresponds to US 5,498,312	w/English abstract
		JP 07-022398	1/24/1995	SONY CORP		w/English abstract
SA		JP 2002-222797 A	8/9/2002	TOKYO ELECTRON LTD		w/English abstract

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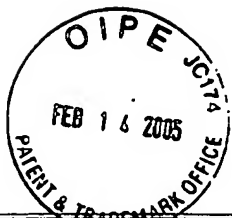
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EXAMINER'S INITIALS	CITE NO.	Foreign Patent Document Country Code ² -Number +-Kind Codes (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines Where Relevant Figures Appear	Translation Yes No
SA		JP 06-188224	7-8-1994	NIPPON MOTOROLA LTD		JAPAN (w/English Abstract)

OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)

EXAMINER'S INITIALS	CITE NO.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.

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